Application/Control No. Applicant(s)/Patent Under Reexamination 10/049,627 TAN ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Peter Coughlan 2129 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY 706/20 US-5,577,166 11-1996 Mizuno, Hirotaka Α US-В US-С US-D US-Ε US-F US-G US-Н US-1 US-US-K US-US-М FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ń 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

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